Band Tuned Enhanced Photodetection in 2D CuInP₂Se₆ Interfaced Silicene for NIR photodetectors

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Abstract

Photodetectors used in current electronic devices to convert optical impulses into electrical signals, have recently been explored for NIR variations [1-2]. Combination of unique narrow-bandgap electronic and optical properties, along with van der Waals (vdW) surface in 2D materials makes them valuable for advancing the capabilities of non-linear near-infrared (NIR) photodetectors. Emerging 2D van der Waals materials have gained additional interest to develop devices with an improved performance, paving the way for innovations in optoelectronics and information technologies. Here, we use first-principles calculations to examine the structural, electronic, and vibrational features of the as-synthesized 2D non-centrosymmetric van der Waals material, CulnP₂Se₆. The study comprehensively investigates various phases, encompassing 2D bulk paraelectric, ferroelectric, and paraelectric monolayer configurations of CuInP₂Se₆. Notably, the narrow energy band spectra of CuInP₂Se₆ exhibit tunability through phase transitions and layer thickness. The results imply that the paraelectric monolayer phase not only displays a notable response in second harmonic generation (SHG) but also demonstrates lower thermal conductivity, suggesting promising applications in nonlinear optics. Near-infrared silicon photodetectors based on two-dimensional paraelectric monolayer CulnP2Se6 material with suitable interfacial encapsulation layer is relatively a new design. Furthermore, ab-initio simulations of monolayer silicene demonstrated the appearance of linear band dispersion in planar and low buckling structures of silicene that was stable [3], used here as an encapsulating layer. The designed Au/ CuInP₂Se₆/Silicene/SiO₂ photodevice for NIR applications exhibited a significant increase in photoconductive gain due to highly efficient pathway for photocarriers as well as an interfacial encapsulation layer. The optoelectronic device studied using a finite element method had a maximum photoresponsivity of 0.23 A/W at 760 nm. This research reveals the potential to revolutionize integrated nano NIR optoelectronic devices, leading the way for future developments.

References

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Figures



Figure 1: Schematics of the NIR Photodetector employing silicene, $CulnP_2Se_6$, and SiO_2